

# 1.2V Drive Pch MOSFET

# RZB002P02

#### Structure

Silicon P-channel MOSFET

#### ● Features

- 1) High speed switing.
- 2) Ultra small package(VMN3).
- 3) Ultra low voltage drive(1.2V drive).

# Application

Switching

# Packaging specifications

•	Package	Taping	
Type	Code	T2L	
	Basic ordering unit (pieces)	8000	
RZB002P0	0		

# ● Absolute maximum ratings (Ta = 25°C)

Param	Symbol	Limits	Unit	
Drain-source voltage		$V_{DSS}$	-20	V
Gate-source voltage		$V_{GSS}$	±10	V
Drain current	Continuous	$I_D$	±200	mA
	Pulsed	I <sub>DP</sub> *1	±800	mA
Source current	Continuous	I <sub>S</sub>	-100	mA
(Body Diode)	Pulsed	I <sub>SP</sub> *1	-800	mA
Power dissipation		P <sub>D</sub> *2	150	mW
Channel temperature		Tch	150	°C
Range of storage temperature		Tstg	-55 to +150	°C

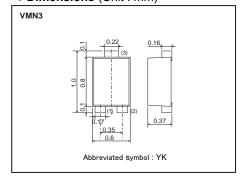
<sup>\*1</sup> Pw≤10µs, Duty cycle≤1%

#### • Thermal resistance

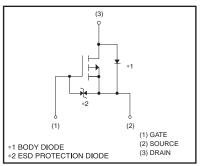
Parameter	Symbol	Limits	Unit
Channel to Ambient	Rth (ch-a)*	833	°C/W

<sup>\*</sup> Each terminal mounted on a recommended land.

# Dimensions (Unit : mm)



#### • Inner circuit



<sup>\*2</sup> Each terminal mounted on a recommended land.

# ● Electrical characteristics (Ta = 25°C)

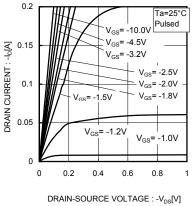
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Gate-source leakage	$I_{GSS}$	-	-	±10	μA	$V_{GS}$ =±10V, $V_{DS}$ =0V
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	-20	-	-	V	I <sub>D</sub> =-1mA, V <sub>GS</sub> =0V
Zero gate voltage drain current	I <sub>DSS</sub>	-	1	-1	μA	$V_{DS}$ =-20V, $V_{GS}$ =0V
Gate threshold voltage	V <sub>GS (th)</sub>	-0.3	1	-1.0	٧	$V_{DS}$ =-10V, $I_{D}$ =-100 $\mu$ A
		-	0.8	1.2		I <sub>D</sub> =-200mA, V <sub>GS</sub> =-4.5V
Otatia dusin sassus as atata		-	1.0	1.5		I <sub>D</sub> =-100mA, V <sub>GS</sub> =-2.5V
Static drain-source on-state resistance	R <sub>DS (on)</sub> *	-	1.3	2.2	Ω	I <sub>D</sub> =-100mA, V <sub>GS</sub> =-1.8V
resistance		-	1.6	3.5		I <sub>D</sub> =-40mA, V <sub>GS</sub> =-1.5V
		-	2.4	9.6		I <sub>D</sub> =-10mA, V <sub>GS</sub> =-1.2V
Forward transfer admittance	IY <sub>fs</sub> I*	0.2	1	-	S	I <sub>D</sub> =-200mA, V <sub>DS</sub> =-10V
Input capacitance	C <sub>iss</sub>	-	115	-	pF	V <sub>DS</sub> =-10V
Output capacitance	C <sub>oss</sub>	-	10	-	pF	V <sub>GS</sub> =0V
Reverse transfer capacitance	C <sub>rss</sub>	-	6	-	pF	f=1MHz
Turn-on delay time	t <sub>d(on)</sub> *	-	6	-	ns	I <sub>D</sub> =-100mA, V <sub>DD</sub> ≒-10V
Rise time	t <sub>r</sub> *	-	4	-	ns	V <sub>GS</sub> =-4.5V
Turn-off delay time	t <sub>d(off)</sub> *	-	17	-	ns	$R_L$ =100 $\Omega$
Fall time	t <sub>f</sub> *	-	17	-	ns	$R_G=10\Omega$
Total gate charge	Q <sub>g</sub> *	-	1.4	-	nC	$I_D = -200 \text{mA}, V_{DD} = -10 \text{V}$
Gate-source charge	Q <sub>gs</sub> *	-	0.3	_	nC	V <sub>GS</sub> =-4.5V
Gate-drain charge	Q <sub>gd</sub> *	-	0.3	-	nC	

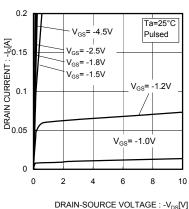
<sup>\*</sup>Pulsed

# ●Body diode characteristics (Source-Drain) (Ta = 25°C)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Forward Voltage	V <sub>SD</sub> *	-	-	-1.2	V	$I_s$ =–200mA, $V_{GS}$ =0V

<sup>\*</sup>Pulsed





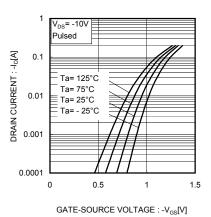
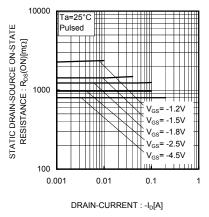
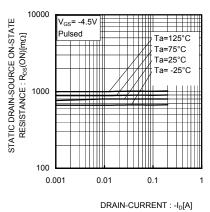


Fig.1 Typical output characteristics( I )

Fig.2 Typical output characteristics( II)

Fig.3 Typical Transfer Characteristics





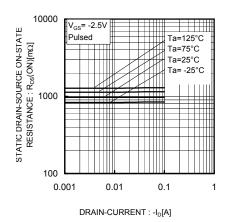
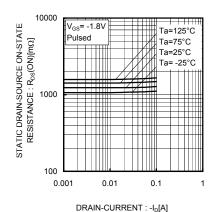
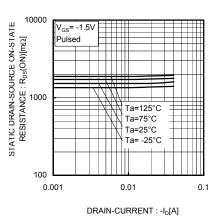


Fig.4 Static Drain-Source On-State Resistance vs. Drain Current( I )

Fig.5 Static Drain-Source On-State Resistance vs. Drain Current( II )

Fig.6 Static Drain-Source On-State Resistance vs. Drain Current( Ⅲ)





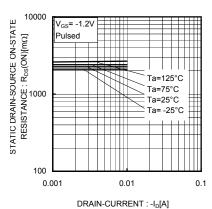


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current( IV)

Fig.8 Static Drain-Source On-State Resistance vs. Drain Current( V)

Fig.9 Static Drain-Source On-State Resistance vs. Drain Current( VI)

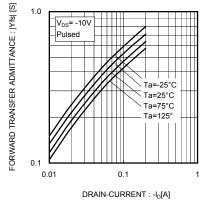


Fig.10 Forward Transfer Admittance vs. Drain Current

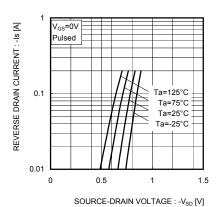


Fig.11 Reverse Drain Current vs. Sourse-Drain Voltage

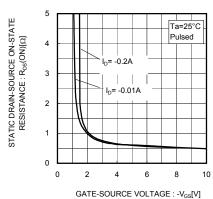


Fig.12 Static Drain-Source On-State
Resistance vs. Gate Source Voltage

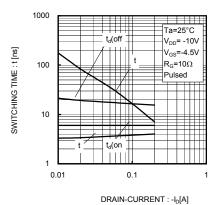


Fig.13 Switching Characteristics

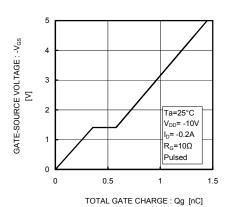


Fig.14 Dynamic Input Characteristics

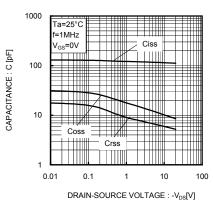


Fig.15 Typical Capacitance vs. Drain-Source Voltage

# Measurement circuits

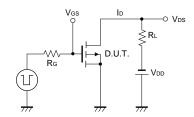


Fig.1-1 Switching Time Measurement Circuit

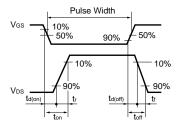


Fig.1-2 Switching Waveforms

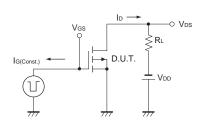


Fig.2-1 Gate charge measurement circuit

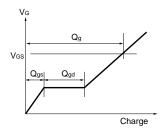


Fig.2-2 Gate Charge Waveform

#### Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

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